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- Power-On Reset Generator
- Automatic Reset Generation After Voltage Drop
- Wide Supply-Voltage Range
- Precision Voltage Sensor
- Temperature-Compensated Voltage Reference
- True and Complement Reset Outputs
- Externally Adjustable Pulse Duration

D OR P PACKAGE (TOP VIEW) REF 1 8 V_{CC} RESIN 2 7 SENSE CT 3 6 RESET GND 4 5 RESET

description

The TL77xxA family of integrated-circuit supply-voltage supervisors is specifically designed for use as reset controllers in microcomputer and microprocessor systems. The supply-voltage supervisor monitors the supply for undervoltage conditions at the SENSE input. During power up, the \overline{RESET} output becomes active (low) when V_{CC} attains a value approaching 3.6 V. At this point (assuming that SENSE is above V_{IT+}), the delay timer function activates a time delay, after which outputs \overline{RESET} and \overline{RESET} go inactive (high and low, respectively). When an undervoltage condition occurs during normal operation, outputs \overline{RESET} and \overline{RESET} go active. To ensure that a complete reset occurs, the reset outputs remain active for a time delay after the voltage at the SENSE input exceeds the positive-going threshold value. The time delay is determined by the value of the external capacitor C_T : $t_d = 1.3 \times 10^4 \times C_T$, where C_T is in farads (F) and t_d is in seconds (s).

During power down (assuming that SENSE is below V_{IT}), the outputs remain active until the V_{CC} falls below a maximum of 2 V. After this, the outputs are undefined.

An external capacitor (typically 0.1 μ F for the TL77xxAC and TL77xxAI) must be connected to REF to reduce the influence of fast transients in the supply voltage.

The TL77xxAC series is characterized for operation from 0°C to 70°C. The TL77xxAI series is characterized for operation from –40°C to 85°C.

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	PACKAGE	CHIP		
TA	SMALL OUTLINE (D)	PLASTIC DIP (P)	FORM (Y)	
0°C to 70°C	TL7702ACD TL7705ACD TL7709ACD TL7712ACD TL7715ACD	TL7702ACP TL7705ACP TL7709ACP TL7712ACP TL7715ACP	TL7702ACY TL7705ACY TL7709ACY TL7712ACY TL7715ACY	
-40°C to 85°C	TL7702AID TL7705AID TL7709AID TL7712AID TL7715AID	TL7702AIP TL7705AIP TL7709AIP TL7712AIP TL7715AIP	_ _ _ _	

The D package is available taped and reeled. Add the suffix R to the device type (e.g., TL7702ACDR). Chip forms are tested at 25°C.



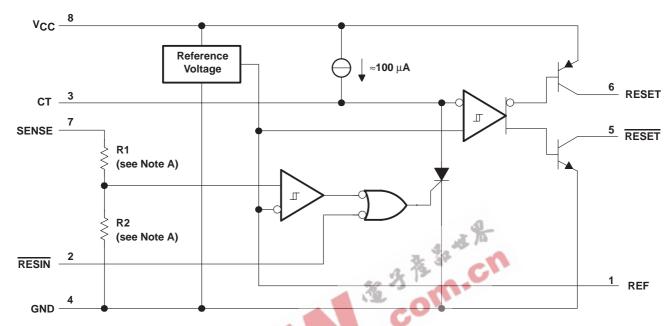
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functional block diagram

The functional block diagram is shown for illustrative purposes only; the actual circuit includes a trimming network to adjust the reference voltage and sense-comparator trip point.



NOTES: A. TL7702A: R1 = 0 Ω , R2 = open

TL7705A: R1 = 7.8 kΩ, R2 = 10 kΩ

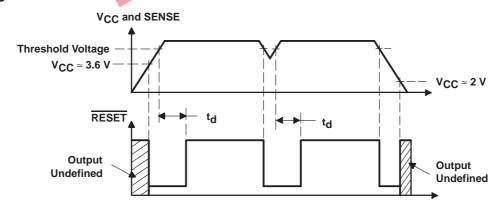
TL7709A: R1 = 19.7 kΩ, R2 = 10 kΩ

TL7712A: R1 = 32.7 k Ω , R2 = 10 k Ω

TL7715A: R1 = 43.4 kΩ, R2 = 10 kΩ

B. Resistor values shown are nominal.

timing diagram



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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)	20 V
Input voltage range, V _I , RESIN	
Input voltage range, V _I , SENSE:TL7702A (see Note 2)	0.3 V to 6 V
TL7705A	0.3 V to 20 V
TL7709A	0.3 V to 20 V
TL7712A, TL7715A	0.3 V to 20 V
High-level output current, I _{OH} , RESET	–30 mA
Low-level output current, IOL, RESET	30 mA
Package thermal impedance, θ _{JA} (see Notes 3 and 4): D package	97°C/W
P package	127°C/W
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D or P package	260°C
Storage temperature range, T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values are with respect to the network ground terminal.
 - 2. For proper operation of the TL7702A, the voltage applied to the SENSE terminal should not exceed V_{CC} 1 V or 6 V, whichever is less.
 - Maximum power dissipation is a function of T_J(max), θ_{JA}, and T_A. The maximum allowable power dissipation at any allowable ambient temperature is P_D = (T_J(max) T_A)/θ_{JA}. Operating at the absolute maximum T_J of 150°C can impact reliability.
 - 4. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions

		MIN	MAX	UNIT
Supply voltage, V _{CC}		3.5	18	V
High-level input voltage at RESIN, VIH		2		V
Low-level input voltage at RESIN, VIL			0.6	V
	TL7702A	0	See Note 2	
	TL7705A	0	10	
Input voltage, SENSE, V _I	TL7709A	0	15	V
	TL7712A	0	20	
	TL7715A	0	20	
High-level output current, RESET, IOH			-16	mA
Low-level output current, RESET, IOL			16	mA
Timing capacitor, C _T			10	μF
TL77xxAC		0	70	°C
Operating free-air temperature range, T _A	TL77xxAI	-40	85	٠٠

NOTE 2: For proper operation of the TL7702A, the voltage applied to the SENSE terminal should not exceed $V_{CC}-1\ V$ or $6\ V$, whichever is less.



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electrical characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER			TEST CONDITIONS [†]		TL77xxAC TL77xxAI		
					MIN	TYP	MAX	
Vон	High-level output voltage, RI	ESET		I _{OH} = -16 mA	V _{CC} -1.5			V
VOL	Low-level output voltage, RE	SET		I _{OL} = 16 mA			0.4	V
V _{ref}	Reference voltage			T _A = 25°C	2.48	2.53	2.58	V
			TL7702A		2.48	2.53	2.58	
			TL7705A		4.5	4.55	4.6	
V _{IT} _	Negative-going input thresho SENSE	old voltage,	TL7709A	T _A = 25°C	7.5	7.6	7.7	V I
	SENSE	TL7712A		10.6	10.8	11		
				TL7715A	13.2	13.5		13.8
			TL7702A			10		
			TL7705A		15			
V_{hys}	Hysteresis, SENSE (V _{IT+} -	V _{IT} _)	TL7709A	T _A = 25°C		20		mV
			TL7712A			35		
			TL7715A			45		
				$V_I = 2.4 \text{ V to } V_{CC}$			20	
Ц	Input current	RESIN		V _I = 0.4 V			-100	μΑ
	5	SENSE	TL7702A	$V_{ref} < V_{I} < V_{CC} - 1.5 V$		0.5	2	
loh	High-level output current, RE	SET		V _O = 18 V			50	μΑ
loL	Low-level output current, RE	SET		V _O = 0			-50	μΑ
Icc	Supply current			All inputs and outputs open		1.8	3	mA

[†] All electrical characteristics are measured with 0.1-μF capacitors connected at REF, CT, and V_{CC} to GND.

switching characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CON	IDITIONS‡		_77xxA0 L77xxAl		UNIT
					MIN	TYP	MAX	
	Output pulse duration		$C_T = 0.1 \mu F$		0.65	1.2	2.6	μs
	Input pulse duration at RESIN				0.4			μs
t _w (S)	Pulse duration at SENSE input to switch output	6	V _{IH} = V _{IT} +200 mV,	V _{IL} = V _{IT} –200 mV	2			μs
^t pd	Propagation delay time, RESIN t	o RESET	V _{CC} = 5 V				1	μs
	Diag time	RESET	V 5 V	Con Note 5			0.2	
t _r	Rise time	RESET	V _{CC} = 5 V, See Note 5				3.5	μs
4.	= 0.0	RESET	V 5 V	Con Note E			3.5	
tf	Fall time RESET		V _{CC} = 5 V, See Note 5				0.2	μs

[‡] All switching characteristics are measured with 0.1-µF capacitors connected at REF and VCC to GND. NOTE 5: The rise and fall times are measured with a 4.7-k Ω load resistor at RESET and RESET.



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electrical characteristics over recommended operating conditions, $T_A = 25^{\circ}C$ (unless otherwise noted)

	PARAMETER		TL77xxAY			UNIT	
	PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	UNIT	
V _{ref}	Reference voltage				2.53		V
		TL7702A			2.53		
	V _{IT} — Negative-going input threshold voltage, SENSE	TL7705A			4.55		
V _{IT} _		TL7709A			7.6		V
		TL7712A			10.8		
		TL7715A			13.5		
		TL7702A			10		
		TL7705A			15		
V _{hys}	Hysteresis, SENSE (V _{IT+} – V _{IT-})	TL7709A			20		mV
	•	TL7712A			35		
		TL7715A			45		
Ц	Input current, SENSE	TL7702A	$V_{ref} < V_I < V_{CC} - 1.5 V$		0.5		μΑ
ICC	Supply current	·	All inputs and outputs open		1.8		mA

[†] All electrical characteristics are measured with 0.1-μF capacitors connected at REF, CT, and V_{CC} to GND.

switching characteristics over recommended operating conditions, T_A = 25°C (unless otherwise noted)

PARAMETER			ATTO CONDITIONST	TL77xxAY			UNIT
		A N	◆TEST CONDITIONS‡	MIN	TYP	MAX	UNII
t _d	Output pulse time delay		C _T = 0.1 μF		1.2		μs

[‡] All switching characteristics are measured with 0.1-μF capacitors connected at REF and V_{CC} to GND.



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PARAMETER MEASUREMENT INFORMATION

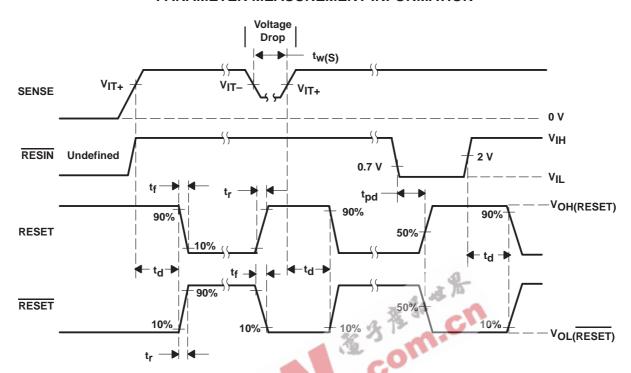
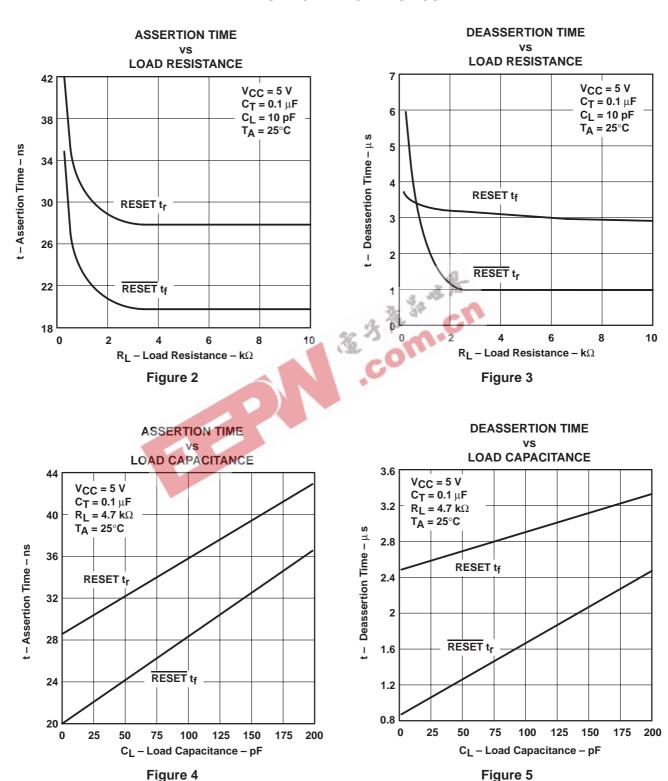


Figure 1. Voltage Waveforms

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TYPICAL CHARACTERISTICS[†]



[†] For proper operation, both RESET and RESET should be terminated with resistors of similar value. Failure to do so may cause unwanted plateauing in either output waveform during switching.



APPLICATION INFORMATION

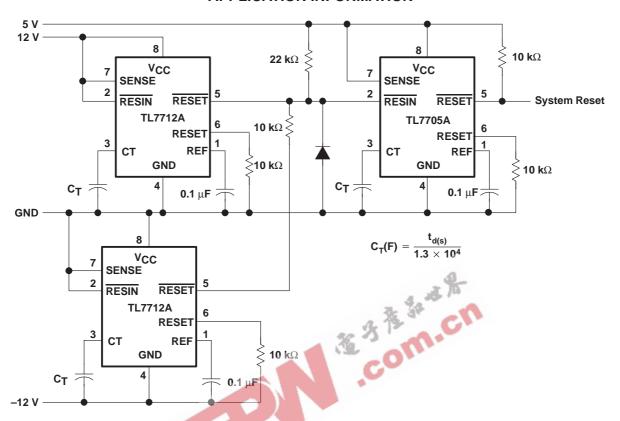


Figure 6. Multiple Power-Supply System Reset Generation

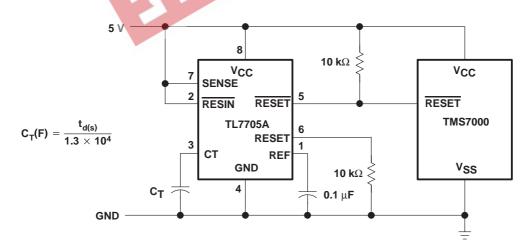


Figure 7. Reset Controller for TMS7000 System

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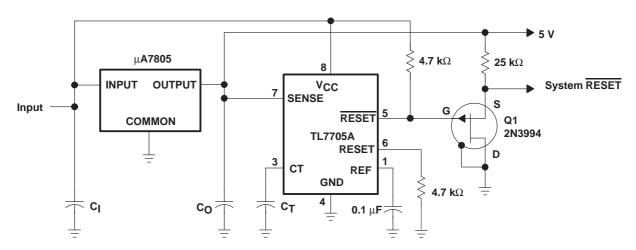


Figure 8. Eliminating Undefined States Using a P-Channel JFET

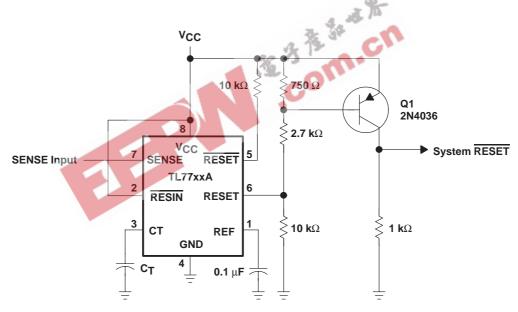


Figure 9. Eliminating Undefined States Using a pnp Transistor

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